

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination CHONG ET AL.	
			Examiner Vincent T. Tran	Art Unit 2115	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,978,281	11-1999	Anand et al.	365/189.05
*	B	US-2001/0004335	06-2001	Murakami, Naoki	365/233
*	C	US-6,509,776	01-2003	Kobayashi et al.	327/277
*	D	US-6,316,980	11-2001	Vogt et al.	327/273
*	E	US-6,279,073	08-2001	McCracken et al.	711/105
*	F	US-6,940,768	09-2005	Dahlberg et al.	365/201
*	G	US-2001/0046163	11-2001	Yanagawa, Miki	365/194
*	H	US-6,492,852	12-2002	Fiscus, Timothy E.	327/158
*	I	US-6,212,113	04-2001	Maeda, Kazunori	365/201
*	J	US-6,295,245	09-2001	Tomita et al.	365/230.08
*	K	US-6,525,585	02-2003	Iida et al.	327/279
*	L	US-6,212,127	04-2001	Funaba et al.	365/233
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.